


<b>Search Notes</b>  	<b>Application/Control No.</b>  10531397	<b>Applicant(s)/Patent Under Reexamination</b>  KLOSTERS ET AL.
	<b>Examiner</b>  Flores, Leon	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	354, 368	11/30/2007	LF
370	509, 510	11/30/2007	LF
327	141	11/30/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	12/11/2007	LF
Checked for possible double patenting.	11/29/2007	LF
Searched in EAST & NPL (IEEE).	11/30/2007	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner